## Notice of References Cited

Application/Control No. 10/644,180	Applicant(s)/Patent Under Reexamination LOGGEN ET AL.		
Examiner	Art Unit		
Christopher P. Schwartz	3683	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-3,668,737	06-1972	Tillmann, Horst	16/55
	В	US-3,701,180	10-1972	Jentsch et al.	16/55
	O	US-4,064,589	12-1977	Bejarano et al.	16/53
	D	US-4,349,939	09-1982	Tillmann, Horst	16/53
	Е	US-4,658,468	04-1987	Tillmann et al.	16/53
	F	US-5,291,630	03-1994	Brown, Peter E.	16/53
	G	US-5,417,013	05-1995	Tillmann, Horst	49/386
	Н	US-5,638,639	06-1997	Goodman et al.	49/7
	1	US-5,802,670	09-1998	Bienek, Volker	16/53
	J	US-5,829,097	11-1998	Toledo, George F.	16/53
	К	US-			
	L	US-			
	М	US-		·	

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р		•			
	α					
	R					
	ø					
	Т					

## **NON-PATENT DOCUMENTS**

*						
<b>.</b> *		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	* V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.